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1. INTRODUCTION

Measurement errors are present in most actual surveys. An easy way to deal with these is to pretend they do not exist, or if they do, assume their effect is negligible. Another approach is to model error and, utilizing complex sample designs, estimate contributions to variance by measurement error (Fellegi, 1964). But cost and time constraints may not allow us to follow this approach. This paper looks at the effect of measurement error on stratified sampling.

2. STRATIFIED SAMPLING

In this section the notation and model used are described. Then, the effect of measurement error on stratified mean estimator and its variance is ascertained. Further, the optimum allocation is determined and the variance of stratified mean under optimum allocation is obtained. This variance is then compared with the variance when measurement errors are absent. Finally, the bias of the standard estimate of variance is obtained.

2.1 Notation and Model

Let a population of N units be divided into H non-overlapping strata (or subpopulations) of

sizes N₁, N₂,..., N_H such that
$$h^{\frac{\Sigma}{2}}_{\pm 1}$$
 N_h = N. For
an estimator $\overline{y}_{st} = \overset{H}{\sum}_{h=1}^{\Sigma} W_h \hat{\overline{Y}}_h$ (1)

where $\hat{\overline{Y}}_h$ is an estimate of the population mean of the y-values of the units in the h-th stratum and W_h (h = 1,2,...,H) are constants, we have

$$Bias(\overline{y}_{st}) = \sum_{h=1}^{n} W_h Bias(\widehat{\overline{Y}}_h)$$
(2)

and

$$V(\overline{y}_{st}) = \sum_{h} W_{h}^{2} V(\hat{\overline{Y}}_{h})$$
(3)

Equation (3) is obtained by assuming samples are selected independently in each stratum. Consider the model

$$y_{hi} = Y_{hi} + \mu_{hi} + e_{hi}$$
$$= Y_{hi} + e_{hi}$$
(4)

where y_{hi} is the observed value of the (h,i)-th unit (h denotes the stratum and i the unit within the stratum); Y_{hi} the true value of the (h,i)-th unit; and μ_{hi} , e_{hi} the bias and error respectively associated with the (h,i)-th unit. This model will hold when an interviewer enumerates the units of only one stratum and all interviewer assigned to a stratum are similar. For samples of n_h and n_1 units from the h-th and 1-th strata respectively, we assume

$$E(e_{hi}|h,i) = 0$$

$$V(e_{hi}|h,i) = \sigma_{h}^{2}$$

$$Cov(e_{hi},e_{hj}|h,i,j) = \rho_{h}\sigma_{h}^{2}, i \neq j$$

$$Cov(e_{hi},e_{lj}|h,l,i,j) = 0, h \neq l$$
(5)

where σ_h^2 is the variation between repeated measurements on any unit in a stratum h and ρ_h , the correlation between measurements on any two units within a stratum. A simple random sample of n_h units is selected without replacement from the h-th stratum. Let

$$\overline{y}_{h} = n_{h}^{-1} \sum_{i}^{n_{h}} y_{hi}$$

$$\overline{Y}_{h}^{*} = N_{h}^{-1} \sum_{i}^{N_{h}} Y_{hi}^{*}$$

$$S_{Y'h}^{2} = (N_{h}^{*} - 1)^{-1} \sum_{i}^{N_{h}} (Y_{hi}^{*} - \overline{Y}_{h}^{*})^{2}$$

2.2 Principal Results

For the estimator

 $\overline{y}_{st} = \Sigma W_h \overline{y}_h$ we have

$$V(\overline{y}_{st}) = \Sigma W_h^2 V(\overline{y}_h)$$

using (3). Under model (4) along with the assumptions (5) we have,

$$V = V(\overline{y}_{st}) = \sum_{h} W_{h}^{2} \{ (\frac{1}{n_{h}} - \frac{1}{N_{h}}) S_{Y'h}^{2} + \frac{\sigma_{h}^{2}}{n_{h}} [1 + (n_{h} - 1)\rho_{h}] \}$$
(6)

We now consider the problem of allocation of sample size to strata. The criterion for determining the vector (n_1, n_2, \ldots, n_H) is either to minimize $V(\overline{y}_{st})$ for a fixed cost or to minimize cost for a fixed variance. Let c_h be the cost of collecting information from a unit in stratum h, and c_0 the overhead cost. Then the total cost of the survey is

$$C = c_0 + \Sigma c_h n_h \tag{7}$$

To determine optimum allocation we shall follow the approach in Raj (1968). The variance of stratified mean is of the form $\Sigma(A_h/n_h)$ where

$$A_{h} = W_{h}^{2} \{ S_{Y'h}^{2} + \sigma_{h}^{2} (1 - \rho_{h}) \}$$

The terms in the variance which are independent of n_h are ignored since they are not pertinent to this problem. Using Cauchy-Schwarz inequality we infer that the product V.C is minimum if and only if

$$\begin{array}{r} n_h \propto W_h \sqrt{\{S_Y^2 \cdot h \, + \, \sigma_h^2(1 \, - \, \rho_h)\}} \ / \ \sqrt{c_h} \\ \text{for all h. Hence} \end{array}$$

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$$\frac{n_{h}}{n} = \frac{W_{h}\sqrt{\{S_{Y'h}^{2} + \sigma_{h}^{2}(1 - \rho_{h})\}/c_{h}}}{\sum_{k} [W_{h}\sqrt{\{S_{Y'h}^{2} + \sigma_{h}^{2}(1 - \rho_{h})\}/c_{h}}]}$$
(8)

This implies that n_h , the size of sample selected from the h-th stratum, should be larger if, for the h-th stratum:

- (1) the Y'-values are more variable, or
- (2) cost of sampling is lower, or
- (3) size N_h is larger, or
- (4) σ_h^2 the within-trial variance is large, or
- (5) ρ_h the correlation between errors is low.

For the no-measurement error case, i.e. σ_h = 0 and μ_h = 0 \forall h, (8) reduces to

$$\frac{n_{h}}{n} = \frac{W_{h}S_{Yh}/\sqrt{c_{h}}}{\sum W_{h}S_{h}/\sqrt{c_{h}}}$$

which is the well known formula for the nomeasurement error case.

We now have the allocation of sample size to strata. Suppose the sample is chosen to minimize $V(\overline{y_{st}})$ for specified cost, then on substituting the optimum values of n_h from (8) in the cost function (7), we have

$$n = \frac{(C - c_0) \sum_h w_h \sqrt{\{S_Y^2 \cdot_h + \sigma_h^2 (1 - \rho_h)\}/c_h}}{\sum_h w_h \sqrt{c_h \{S_Y^2 \cdot_h + \sigma_h^2 (1 - \rho_h)\}}}$$
(9)

If V is fixed, then n can be found by substituting the optimum values of n_h in the equation (6).

If $c_h = c$ for h = 1, 2, ..., H, then the cost is

$$C = c_0 + cn$$

and optimum allocation for fixed cost reduces to optimum allocation for fixed ${\tt n}.$ Then

$$n_{h} = \frac{nW_{h}\sqrt{S_{Y'h}^{2} + \sigma_{h}^{2}(1 - \rho_{h})}}{\Sigma W_{h}\sqrt{S_{Y'h}^{2} + \sigma_{h}^{2}(1 - \rho_{h})}}$$
(10)

This allocation will be called the modified Neyman allocation. Again, when measurement errors are absent, equation (10) reduces to

$$n_{h} = n \frac{W_{h}S_{Yh}}{\Sigma W_{h}S_{Yh}}$$

The minimum value of $V(y_{st})$ when n is fixed is

$$V_{\min}(\overline{y}_{st}) = \frac{1}{n} \cdot (\Sigma W_h \sqrt{S_Y^2 \cdot h} + \sigma_h^2 (1 - \rho_h))^2 - \Sigma \frac{W_h^2 S_Y^2 \cdot h}{N_h} + \Sigma W_h^2 \sigma_h^2 \rho_h$$
(11)

This allocation is optimum when measurement errors are considered. Equation (11), under nomeasurement error case, reduces to

$$V_{\min}(\text{no-error}) = \frac{1}{n} (\Sigma W_h S_{Yh})^2 - \Sigma \frac{W_h^2 S_{Yh}^2}{N_h}$$
(12)

Also, on comparing the measurement error case with the no-measurement error case, we have

 $V_{\min} - V_{\min}(\text{no-error}) =$

$$\frac{1}{n} (\Sigma W_h \sqrt{S_Y^2 \cdot_h} + \sigma_h^2 (1 - \rho_h))^2$$
$$- \frac{1}{n} (\Sigma W_h S_{Yh})^2$$
$$- \Sigma \frac{W_h^2 S_{Yh}^2}{N_h} + \Sigma \frac{W_h^2 S_{Yh}^2}{N_h}$$
$$+ \Sigma W_h^2 \sigma_h^2 \rho_h$$

Assume $S_{Y'h} = S_{Yh}$ and to simplify expressions let

$$\begin{split} \mathbf{S}_{\mathbf{mh}} &= \mathbf{v} \mathbf{S}_{\mathbf{Yh}}^{2} + \sigma_{\mathbf{h}}^{2} (1 - \rho_{\mathbf{h}}), \text{ then} \\ \mathbf{n} \{ \mathbf{V}_{\mathbf{min}} - \mathbf{V}_{\mathbf{min}} (\mathbf{n} \cdot \mathbf{error}) \} &= (\Sigma \ \mathbf{W}_{\mathbf{h}} \mathbf{S}_{\mathbf{mh}})^{2} \\ &- (\Sigma \ \mathbf{W}_{\mathbf{h}} \mathbf{S}_{\mathbf{Yh}})^{2} + \mathbf{n} \Sigma \mathbf{W}_{\mathbf{h}}^{2} \sigma_{\mathbf{h}}^{2} \rho_{\mathbf{h}} \\ &= \Sigma \mathbf{W}_{\mathbf{h}}^{2} [\mathbf{S}_{\mathbf{Yh}}^{2} + \sigma_{\mathbf{h}}^{2} (1 - \rho_{\mathbf{h}})] \\ &+ \sum_{\mathbf{h} \neq \ell} \mathbf{W}_{\mathbf{h}} \mathbf{W}_{\mathbf{S}} \mathbf{S}_{\mathbf{m}} \mathbf{S}_{\mathbf{m}\ell} \\ &- \Sigma \mathbf{W}_{\mathbf{h}}^{2} \mathbf{S}_{\mathbf{Yh}}^{2} - \sum_{\mathbf{h} \neq \ell} \mathbf{W}_{\mathbf{h}} \mathbf{W}_{\ell} \mathbf{S}_{\mathbf{Yh}} \mathbf{S}_{\mathbf{Y}\ell} \\ &+ \mathbf{n} \Sigma \ \mathbf{W}_{\mathbf{h}}^{2} \sigma_{\mathbf{h}}^{2} \rho_{\mathbf{h}} \\ &= \Sigma \ \mathbf{W}_{\mathbf{h}}^{2} \sigma_{\mathbf{h}}^{2} \{1 + (\mathbf{n} - 1) \rho_{\mathbf{h}} \} \\ &+ \Sigma \ \mathbf{W}_{\mathbf{h}} \mathbf{W}_{\ell} \{\mathbf{S}_{\mathbf{m}\mathbf{h}} \mathbf{S}_{\mathbf{m}\ell} - \mathbf{S}_{\mathbf{V}\mathbf{h}} \mathbf{S}_{\mathbf{Y}\ell} \} \end{split}$$

 $h \neq \ell$ $h'' \ell'' mh'' m \ell'' Yh' Y \ell''$ If $\rho_h \ge -(n-1)^{-1}$, which is usually the case, then variance under measurement error is greater than variance when measurement error is absent. However, if $\rho_h < -(n-1)^{-1}$, then variance under measurement error can be smaller than variance when measurement error is not present.

Next, consider the standard estimate of variance of \overline{y}_{st} ,

$$\mathbf{v}(\overline{\mathbf{y}}_{st}) = \frac{1}{N^2} \Sigma N_h (N_h - n) \frac{S_h^2}{n_h}$$

where

$$s_{h}^{2} = (n_{h} - 1)^{-1} \frac{\Sigma_{h}}{\Sigma_{i=1}} (y_{hi} - \overline{y}_{h})^{2}$$

Using the result for simple random sampling without replacement (Chandhok, 1982)

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$$E[(1 - f)\{n(n - 1)\}^{-1} \sum_{j=1}^{n} (y_j - \overline{y})^2]$$

= (1 - f)(nN)^{-1} \Sigma (Y_j - \overline{Y})^2
- N^{-2} \Sigma \sigma_j^2 (1 - \rho) - \rho N^{-2} (\Sigma \sigma_j)^2

We can easily see that

$$E\{v(\overline{y}_{st})\} = V(\overline{y}_{st}) - N^{-2} \Sigma N_{h} (1 - \rho_{h}) \sigma_{h}^{2}$$
$$- N^{-2} \Sigma \rho_{h} \sigma_{h}^{2}$$

If the measurement errors are positively correlated, which is usually the case, then the usual estimator underestimates the variance. Even if measurement errors are uncorrelated, this estimator underestimates the variance. However, if measurement error is negatively correlated, this estimator can overestimate the true variance.

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